

IRFP240, IRFP241, IRFP242, IRFP243

18A and 20A, 200V and 150V, 0.18 and 0.22 Ohm, N-Channel Power MOSFETs

January 1998

Features

- 18A and 20A, 200V and 150V
- $r_{DS(ON)} = 0.18\Omega$ and 0.22Ω
- Single Pulse Avalanche Energy Rated
- · SOA is Power Dissipation Limited
- Nanosecond Switching Speeds
- · Linear Transfer Characteristics
- · High Input Impedance
- Related Literature
 - TB334 "Guidelines for Soldering Surface Mount Components to PC Boards"

Description

These are N-Channel enhancement mode silicon gate power field effect transistors. They are advanced power MOSFETs designed, tested, and guaranteed to withstand a specified level of energy in the breakdown avalanche mode of operation. All of these power MOSFETs are designed for applications such as switching regulators, switching convertors, motor drivers, relay drivers, and drivers for high power bipolar switching transistors requiring high speed and low gate drive power. These types can be operated directly from integrated circuits.

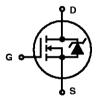
Formerly developmental type TA17422.

Ordering Information

PART NUMBER	PACKAGE	BRAND
IRFP240	TO-247	IRFP240
IRFP241	TO-247	IRFP241
IRFP242	TO-247	IRFP242
IRFP243	TO-247	IRFP243

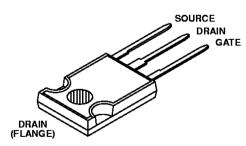
NOTE: When ordering, include the entire part number.

Symbol



Packaging

JEDEC STYLE TO-247



IRFP240, IRFP241, IRFP242, IRFP243

Absolute Maximum Ratings T_C = 25°C, Unless Otherwise Specified IRFP240 IRFP242 UNITS IRFP241 IRFP243 200 150 200 150 Drain to Gate Voltage ($R_{GS} = 20k\Omega$) (Note 1) V_{DGR} 200 200 ٧ 150 150 20 20 18 18 Α $T_C = 100^{\circ}C$ 12 12 11 11 80 80 72 72 Α Gate to Source Voltage......V_{GS} ±20 ±20 ±20 v ±20 Maximum Power Dissipation.....PD 150 150 150 150 W W/°C 1.2 1.2 1.2 1.2 Single Pulse Avalanche Energy Rating (Note 4) EAS 510 510 510 510 mЈ -55 to 150 -55 to 150 -55 to 150 -55 to 150 ٥С Maximum Temperature for Soldering Leads at 0.063in (1.6mm) from Case for 10s T_L ٥С 300 300 300 300 Package Body for 10s, See Techbrief 334 T_{pkg} ٥С 260 260 260 260

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTE:

1. $T_J = 25^{\circ}C$ to $125^{\circ}C$.

Electrical Specifications T_C = 25°C, Unless Otherwise Specified

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNITS
Drain to Source Breakdown Voltage	BV _{DSS}	V _{GS} = 0V, I _D = 250μA, (Figure 10)				
IRFP240, IRFP242				-	-	٧
IRFP241, IRFP243				-	-	٧
Gate to Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \mu A$	2.0	-	4.0	٧
Zero-Gate Voltage Drain Current	IDSS	V _{DS} = Rated BV _{DSS} , V _{GS} = 0V	-	-	25	μΑ
		V_{DS} = 0.8 x Rated BV _{DSS} , V_{GS} = 0V, T_{J} = 125°C	1	-	250	μΑ
On-State Drain Current (Note 2) IRFP240, IRFP241	I _{D(ON)}	V _{DS} > I _{D(ON) x} r _{DS(ON)MAX} , V _{GS} = 11V, (Figure 7)		-	-	А
IRFP242, IRFP243				-	-	Α
Gate to Source Leakage	IGSS	V _{GS} = ±20V	-	-	±100	пA
Drain to Source On Resistance (Note 2) IRFP240, IRFP241	^r DS(ON)	V _{GS} = 10V, I _D = 10A, (Figures 8, 9)		0.14	0.18	Ω
IRFP242, IRFP243				0.20	0.22	Ω
Forward Transconductance (Note 2)	9fs	V _{DS} ≥ 50V, I _D = 11A	7.3	11	-	S
Turn-On Delay Time	t _d (ON)	$\begin{split} &V_{DD}=100V,\ I_D\approx 18A,\ R_G=9.1\Omega,\ V_{GS}=10V,\\ &R_L=5.4\Omega,\ (\text{Figures }17,\ 18)\\ &MOSFET \ Switching \ Times \ are \ essentially \ Independent \ of \ Operating \ Temperature \end{split}$		14	21	ns
Rise Time	t _r			51	77	ns
Turn-Off Delay Time	ધ(OFF)			45	68	ns
Fall Time	t _f			36	54	ns
Total Gate Charge (Gate to Source + Gate to Drain)	Q _{g(TOT)}	$V_{GS} = 10V$, $I_D = 18A$, $V_{DS} = 0.8 \times Rated BV_{DSS}$, $I_{G(REF)} = 1.5mA$, (Figure 14, 19, 20)	-	43	60	пC
Gate to Source Charge	Q _{gs}	Gate Charge is Essentially Independent of Operating Temperature		10	-	пC
Gate to Drain "Miller" Charge	Q _{gd}			32	-	пC
Input Capacitance	C _{ISS}	V _{GS} = 0V, V _{DS} = 25V, f = 1.0MHz, (Figure 11)		1275	-	pF
Output Capacitance	Coss			500	-	pF
Reverse Transfer Capacitance	C _{RSS}			160	-	рF

IRFP240, IRFP241, IRFP242, IRFP243

Electrical Specifications $T_C = 25$ °C, Unless Otherwise Specified (Continued)

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Internal Drain Inductance	L _D	Measured Between the Contact Screw on Header that is Closer to Source and Gate Pins and Center of Die	Modified MOSFET Symbol Showing the Internal Devices Inductances	-	5.0	-	nH
Internal Source Inductance	L _S	Measured from the Source Lead, 6mm (0.25in) from Header to Source Bonding Pad	G ELS	-	12.5	-	nΗ
Junction to Case	R ₀ JC			-	-	0.83	°C/W
Junction to Ambient	$R_{\theta JA}$	Free Air Operation		-	-	30	°C/W

Source to Drain Diode Specifications

PARAMETER	SYMBOL	TEST CONDITIONS		MIN	TYP	MAX	UNITS
Continuous Source to Drain Current	I _{SD}	Modified MOSFET	9 D	-	-	20	Α
Pulse Source to Drain Current (Note 3)	^I SDM	Symbol Showing the Integral Reverse P-N Junction Diode	G S S	1	1	80	А
Source to Drain Diode Voltage (Note 2)	V_{SD}	$T_J = 25^{\circ}C$, $I_{SD} = 18A$,	V _{GS} = 0V, (Figure 13)	-	-	2.0	V
Reverse Recovery Time	t _{rr}	$T_J = 25^{\circ}C$, $I_{SD} = 18A$,	dl _{SD} /dt = 100A/μs	120	250	530	ns
Reverse Recovered Charge	Q _{RR}	$T_J = 25^{\circ}C$, $I_{SD} = 18A$,	dl _{SD} /dt = 100A/μs	1.3	2.6	5.6	μC

NOTES:

- 2. Pulse test: pulse width \leq 300 μ s, duty cycle \leq 2%.
- 3. Repetitive rating: pulse width limited by Max junction temperature. See Transient Thermal Impedance curve (Figure 3).
- 4. V_{DD} = 50V, starting T_J = 25°C, L = 1.9mH, R_{GS} = 50 Ω , peak I_{AS} = 20A (Figures 14, 15).

Typical Performance Curves Unless Otherwise Specified

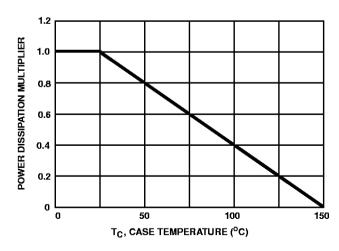


FIGURE 1. NORMALIZED POWER DISSIPATION vs CASE TEMPERATURE

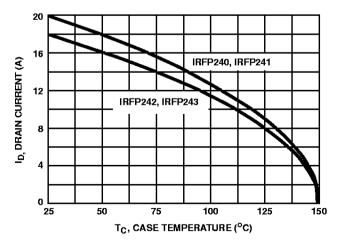
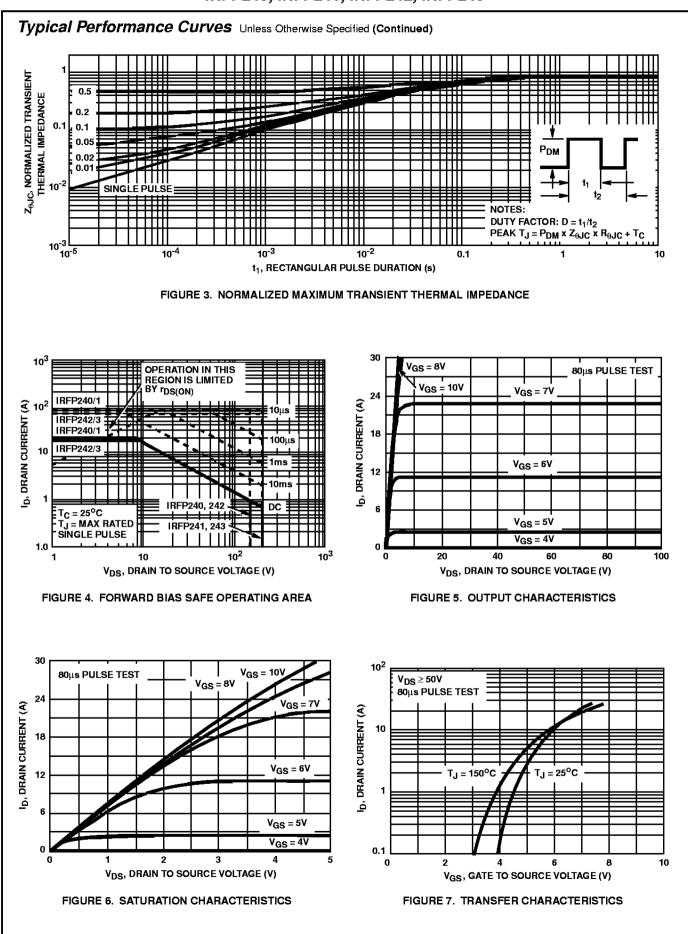
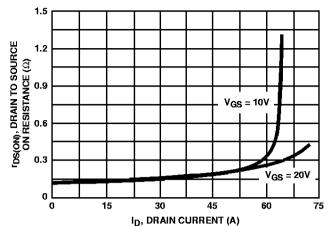


FIGURE 2. MAXIMUM CONTINUOUS DRAIN CURRENT vs CASE TEMPERATURE



Typical Performance Curves Unless Otherwise Specified (Continued) 1.5

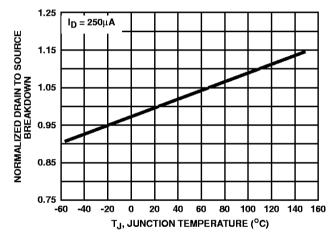


3.0 V_{GS} = 10V 2.4 V_{GS} = 10

NOTE: Heating effect of $2\mu s$ pulse is minimal.

FIGURE 8. DRAIN TO SOURCE ON RESISTANCE GATE VOLTAGE AND DRAIN CURRENT

FIGURE 9. NORMALIZED DRAIN TO SOURCE ON RESISTANCE VS JUNCTION TEMPERATURE



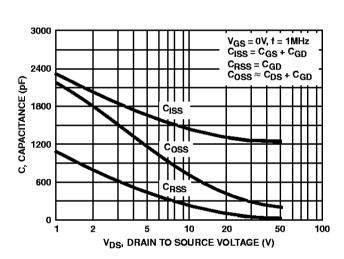
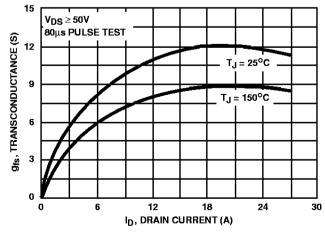


FIGURE 10. NORMALIZED DRAIN TO SOURCE BREAKDOWN VOLTAGE VS JUNCTION TEMPERATURE

FIGURE 11. CAPACITANCE vs DRAIN TO SOURCE VOLTAGE



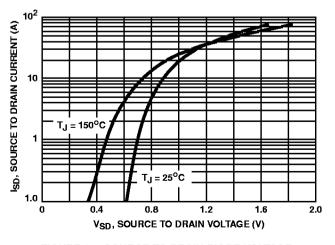


FIGURE 12. TRANSCONDUCTANCE vs DRAIN CURRENT

FIGURE 13. SOURCE TO DRAIN DIODE VOLTAGE

Typical Performance Curves Unless Otherwise Specified (Continued)

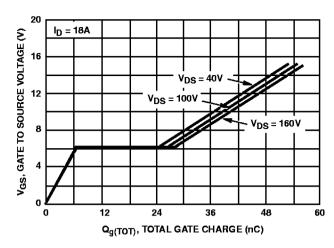


FIGURE 14. GATE TO SOURCE VOLTAGE vs GATE CHARGE

Test Circuits and Waveforms

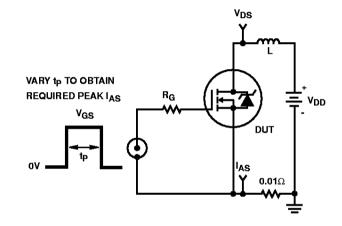


FIGURE 15. UNCLAMPED ENERGY TEST CIRCUIT

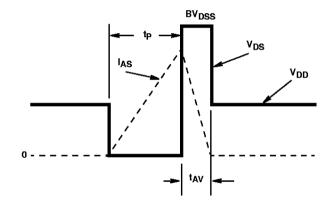


FIGURE 16. UNCLAMPED ENERGY WAVEFORMS

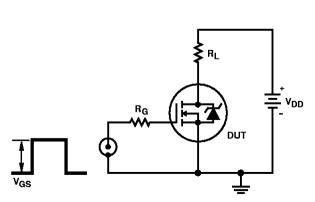


FIGURE 17. SWITCHING TIME TEST CIRCUIT

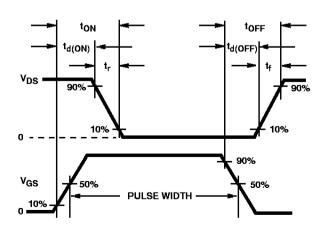
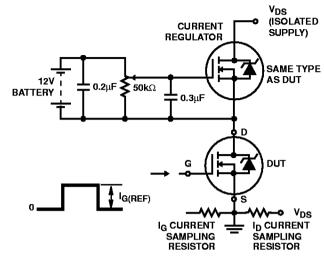


FIGURE 18. RESISTIVE SWITCHING WAVEFORMS

Test Circuits and Waveforms (Continued)



V_{DD}
Q_g(TOT)
V_{GS}
V_{DS}
O

FIGURE 19. GATE CHARGE TEST CIRCUIT

FIGURE 20. GATE CHARGE WAVEFORMS

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